Applicant(s)/Patent Under Application/Control No. Reexamination 10/723,436 OYAMA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Donghai D. Nguyen 3729 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY * 08-1992 382/153 US-5,140,643 A Izumi et al. Α US-5,195,821 A 03-1993 Eguchi, Shigeru 29/834 В 356/394 US-5,461,480 A С 10-1995 Yamada et al. US-D Ε US-F US-G US-USн US-J US-US-Κ L US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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